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## RENESAS

# MOS INTEGRATED CIRCUIT μ**PD178F124**

## 8-BIT SINGLE-CHIP MICROCONTROLLER

#### DESCRIPTION

The µPD178F124 is a flash memory model of the µPD178023 and 178024, and is provided with a flash memory to/from which data can be written/erased with the microcontroller mounted on a printed circuit board.

For the detailed functional description, refer to the following User's Manuals: µPD178024, 178124 Subseries User's Manual: U13915E

#### 78K/0 Series User's Manual - Instruction : U12326E

#### **FEATURES**

- Serial interface (I<sup>2</sup>C bus and UART mode)
- · Hardware for PLL frequency synthesizer
- Pin-compatible with mask ROM models (except VPP pin)
- Flash memory: 32K bytes<sup>Note</sup>
- Internal high-speed RAM: 1024 bytes
- Operable at same supply voltage as mask ROM models: VDD = 4.5 to 5.5 V (during CPU and PLL operations)

: VDD = 3.5 to 5.5 V (during CPU operation)

**Note** The capacities of the flash memory can be changed using the memory size select register (IMS).

Remark For the differences between the flash memory model and mask ROM models, refer to 1. DIFFERENCES BETWEEN µPD178F124 AND MASK ROM MODELS.

The electrical specifications (such as supply current) in the  $\mu$ PD178F124 differ from those of the mask ROM models. Confirm these differences before mass-producing any application set.

#### **APPLICATION FIELD**

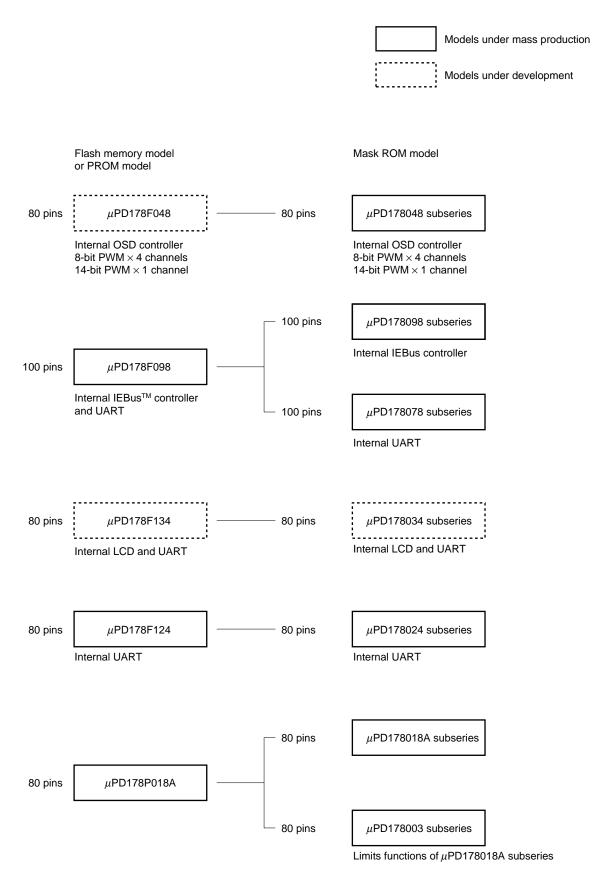
Car stereos

#### **ORDERING INFORMATION**

Part Number	Package
μPD178124GF-3B9	80-pin plastic QFP (14 $ imes$ 20)
μPD178124GC-8BT	80-pin plastic QFP (14 $ imes$ 14)

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

#### **DEVELOPMENT OF 8-BIT DTS SERIES**



## FUNCTIONAL OUTLINE

(1/2)

Item		μPD178F124				
Internal	Flash memory	32 Kbytes				
	High-speed RAM	1024 bytes				
General-pur	pose register	8 bits $\times$ 32 registers (8 bits $\times$ 8 registers $\times$ 4 banks)				
Minimum ins	struction execution time	0.45 $\mu$ s/0.89 $\mu$ s/1.78 $\mu$ s/3.56 $\mu$ s/7.11 $\mu$ s (with crystal resonator of fx = 4.5 MHz)				
Instruction s	et	<ul> <li>16-bit operation</li> <li>Multiplication/division (8 bits × 8 bits, 16 bits ÷ 8 bits)</li> <li>Bit manipulation (set, reset, test, Boolean operation)</li> <li>BCD adjustment, etc.</li> </ul>				
I/O port		Total       : 62 pins         • CMOS I/O       : 53 pins         • CMOS input       : 6 pins         • N-ch open-drain output : 3 pins				
A/D converte	er	8-bit resolution $\times$ 6 channels (VDD = 3.5 to 5.5 V)				
Serial interface		<ul> <li>I<sup>2</sup>C bus mode<sup>Note</sup>: 1 channel</li> <li>3-wire mode : 1 channel</li> <li>UART mode : 1 channel</li> </ul>				
Timer		<ul> <li>Basic timer (timer carry FF (10 Hz)): 1 channel</li> <li>8-bit timer/event counter : 2 channels</li> <li>Watchdog timer : 1 channel</li> </ul>				
Buzzer outp	ut	1 channel (1 kHz, 1.5 kHz, 3 kHz, 4 kHz)				
Vectored interrupt	Maskable	Internal : 11 External: 5				
source	Non-maskable	Internal: 1				
	Software	1				
PLL frequency synthesizer	Division mode	2 types • Direct division mode (VCOL pin) • Pulse swallow mode (VCOL and VCOH pins)				
	Reference frequency	Seven types selectable in software (1, 3, 9, 10, 12.5, 25, 50 kHz)				
	Charge pump	Error out output: 2 pins				
	Phase comparator	Unlock detectable in software				

**Note** When the I<sup>2</sup>C bus mode is used (including when the mode is implemented in software without using the peripheral hardware), consult NEC when ordering a mask.

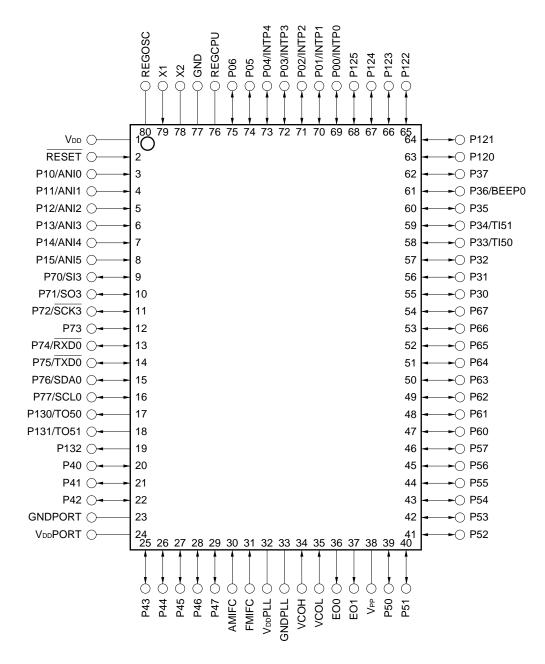
(2/2)

Item	μPD178F124
Frequency counter	Frequency measurement • AMIFC pin: For 450-kHz counting • FMIFC pin: For 450-kHz/10.7-MHz counting
Reset	<ul> <li>Reset by RESET pin</li> <li>Internal reset by watchdog timer</li> <li>Reset by power-ON clear circuit</li> <li>Detection of less than 4.5 V<sup>Note</sup> (Reset does not occur, however.)</li> <li>Detection of less than 3.5 V<sup>Note</sup> (during CPU operation)</li> <li>Detection of less than 2.3 V<sup>Note</sup> (in STOP mode)</li> </ul>
Supply voltage	<ul> <li>V<sub>DD</sub> = 4.5 to 5.5 V (during CPU, PLL operation)</li> <li>V<sub>DD</sub> = 3.5 to 5.5 V (during CPU operation)</li> </ul>
Package	<ul> <li>80-pin plastic QFP (14 × 20)</li> <li>80-pin plastic QFP (14 × 14)</li> </ul>

**Note** These voltages are the maximum values. In practice, the chip may be reset at voltages lower than these.

#### **PIN CONFIGURATION (Top View)**

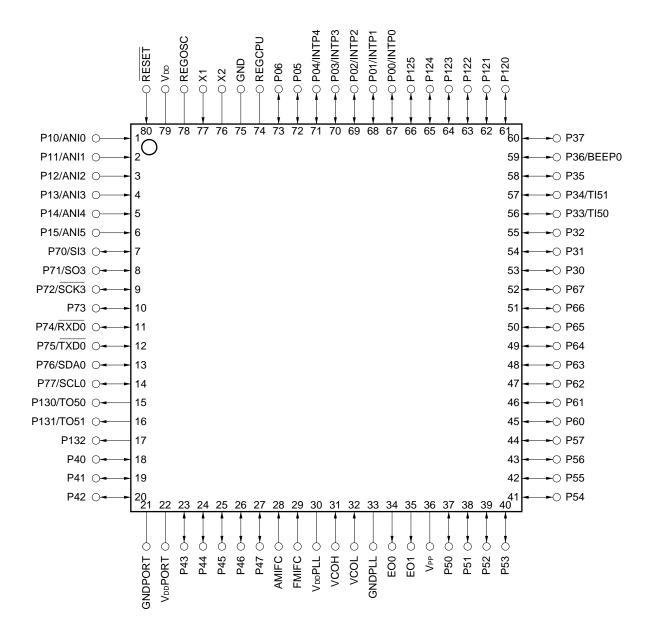
 80-pin plastic QFP (14 × 20) μPD178F124GF-3B9



Cautions 1. Directly connect the VPP to GND in normal operating mode.

- 2. Keep the voltage at VDDPORT and VDDPLL at the same voltage as VDD.
- 3. Keep the voltage at GNDPORT and GNDPLL at the same voltage as GND.
- 4. Connect each of the REGOSC and REGCPU pins to GND via 0.1- $\mu$ F capacitor.

• 80-pin plastic QFP (14  $\times$  14)  $\mu \text{PD178F124GC-8BT}$ 



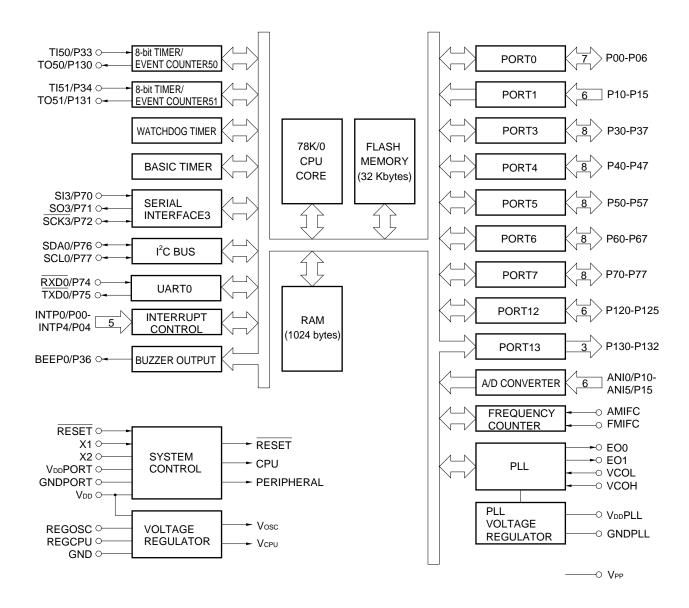
Cautions 1. Directly connect the VPP to GND in normal operating mode.

- 2. Keep the voltage at VDDPORT and VDDPLL at the same voltage as VDD.
- 3. Keep the voltage at GNDPORT and GNDPLL at the same voltage as GND.
- 4. Connect each of the REGOSC and REGCPU pins to GND via 0.1- $\mu$ F capacitor.

## PIN NAME

AMIFC	: AM intermediate frequency counter input	REGCPU	: Regulator for CPU power supply
ANIO-ANI5	: A/D converter input	REGOSC	: Regulator for oscillator
BEEP0	: Buzzer output	RESET	: Reset input
EO0, EO1	: Error out output	RXD0	: Serial (UART0) data input
FMIFC	: FM intermediate frequency counter input	SCK3	: Serial (SIO3) clock input/output
GND	: Ground	SCL0	: Serial (IIC0) clock input/output
GNDPLL	: PLL ground	SDA0	: Serial (IIC0) data input/output
GNDPORT	: Port ground	SI3	: Serial (SIO3) data input
INTP0-INT	P4 : Interrupt input	SO3	: Serial (SIO3) data output
P00-P06	: Port 0	TI50, TI51	: 8-bit timer clock input
P10-P15	: Port 1	TO50, TO51	I: 8-bit timer output
P30-P37	: Port 3	TXD0	: Serial (UART0) data output
P40-P47	: Port 4	VCOL, VCC	H: Local oscillation input
P50-P57	: Port 5	Vdd	: Power supply
P60-P67	: Port 6	VddPLL	: PLL power supply
P70-P77	: Port 7	VDDPORT	: Port power supply
P120-P128	5 : Port 12	Vpp	: Programming power supply
P130-P132	2 : Port 13	X1, X2	: Crystal resonator

#### **BLOCK DIAGRAM**



NEC

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#### 1. DIFFERENCES BETWEEN $\mu\text{PD178F124}$ and Mask rom models

The  $\mu$ PD178F124 is provided with a flash memory to/from which data can be rewritten/erased with the device mounted on a printed circuit board. The differences between the flash memory model ( $\mu$ PD178F124) and mask ROM models ( $\mu$ PD178023 and 178024) are shown in Table 1-1.

Item		μPD178F124	μPD178023, 178024
Internal memory ROM structure ROM capacity		Flash memory	Mask ROM
		32K bytes	μPD178023 : 24K bytes μPD178024 : 32K bytes
Internal ROM capacity selected by memory size select register (IMS)		Equivalent to mask ROM model	μPD178023:C6H μPD178024:C8H
IC pin		Not provided	Provided
VPP pin		Provided	Not provided
Electrical specifications, recommended soldering conditions		See the relevant data sheet.	

## 2. PIN FUNCTION LIST

#### 2.1 Port Pins

Pin Name	I/O	Function	At Reset	Shared by:
P00-P04	I/O	Port 0.	Input	INTP0-INTP4
P05, P06		7-bit I/O port. Can be set in input or output mode in 1-bit units.		_
P10-P15	Input	Port 1. 6-bit input port.	Input	ANIO-ANI5
P30-P32	I/O	Port 3.	Input	_
P33		8-bit I/O port. Can be set in input or output mode in 1-bit units.		TI50
P34		Can be set in input of output mode in 1-bit units.		TI51
P35	_			
P36	_			BEEP0
P37	-			_
P40-47	I/O	Port 4. 8-bit I/O port. Can be set in input or output mode in 1-bit units. Internal pull-up resistors can be specified in software. Interrupt function by key input is provided.	Input	-
P50-P57	I/O	Port 5. 8-bit I/O port. Can be set in input or output mode in 1-bit units.	Input	-
P60-P67	I/O	Port 6. 8-bit I/O port. Can be set in input or output mode in 1-bit units.	Input	-
P70	I/O	Port 7.	Input	SI3
P71	_	8-bit I/O port.		SO3
P72	_	Can be set in input or output mode in 1-bit units.		SCK3
P73	_			
P74	_			RXD0
P75	-			TXD0
P76	1			SDA0
P77	1			SCL0
P120-P125	I/O	Port 12. 6-bit I/O port. Can be set in input or output mode in 1-bit units.	Input	_
P130	Output	Port 13.	Low-level	TO50
P131	1	3-bit output port.	output	TO51
P132	-	N-ch open-drain output port (12 V withstand)		_

## 2.2 Pins Other Than Port Pins

Pin Name	I/O	Function	At Reset	Shared by:		
INTP0-INTP4	Input	External maskable interrupt input whose v (rising edge, falling edge, or both rising an can be specified.	Input	P00-P04		
SI3	Input	Serial data input to serial interface.		Input	P70	
SO3	Output	Serial data output from serial interface.		Input	P71	
SDA0	I/O	Serial data input/output to/from N- serial interface.	-ch open drain I/O	Input	P76	
SCK3	I/O	Serial clock input/output to/from serial inte	erface.	Input	P72	
SCL0		N-	ch open drain I/O		P77	
RXD0	Input	Serial data input to asynchronous serial ir	nterface (UART0).	Input	P74	
TXD0	Output	Serial data output from asynchronous seria	al interface (UART0).		P75	
TI50	Input	External count clock input to 8-bit timer (1	ГМ50).	Input	P33	
TI51		External count clock input to 8-bit timer (7	ΓM51).		P34	
TO50	Output	8-bit timer (TM50) output.		Low-level	P130	
TO51		8-bit timer (TM51) output.		output	P131	
BEEP0	Output	Buzzer output.	Input	P36		
ANI0-ANI5	Input	Analog input to A/D converter.	Input	P10-P15		
EO0, EO1	Output	Error out output from charge pump of PLL synthesizer.	-	_		
VCOL	Input	Inputs local oscillation frequency of PLL (in	HF and MF modes).	-	-	
VCOH		Inputs local oscillation frequency of PLL (	in VHF mode).			
AMIFC	Input	Input to AM intermediate frequency count	er.	Input	-	
FMIFC		Input to FM or AM intermediate frequency				
RESET	Input	System reset input.	_	-		
X1	Input	Connection of crystal resonator for system	_	-		
X2	_		_	-		
REGOSC	_	Regulator for oscillator. Connect this pin capacitor.	to GND via 0.1-μF	-	-	
REGCPU	_	Regulator for CPU power supply. Connect via 0.1-µF capacitor.	ct this pin to GND	-	-	
Vdd	_	Positive power supply.		_	-	
GND	-	Ground.		_	-	
VDDPORT	_	Port power supply.		-	-	
GNDPORT	_	Port ground.		-	-	
	_	PLL positive power supply.		_	-	
	_	PLL ground.		_	-	
Vpp	_	Setting flash memory programming mode. Applying high voltage for program write/ver Connect directly to GND or GNDPORT in no	-	_		

**Note** Connect a capacitor of about 1000 pF between the VDDPLL and GNDPLL pins.

## 2.3 I/O Circuits of Pins and Recommended Connections of Unused Pins

Table 2-1 shows the types of the I/O circuits of the respective pins and the recommended connections of the pins when they are not used. For the configuration of the I/O circuit of each pin, refer to Figure 2-1.

Pin Name	I/O Circuit Type	I/O	Recommended Connection of Unused Pin			
P00/INTP0-P04/INTP4	8	I/O	Set these pins in general-purpose input mode in software, and connect			
P05, P06			each of them to VDD, VDDPORT, GND, or GNDPORT via resistor.			
P10/ANI0-P15/ANI5	25	Input	Connect each of them to VDD, VDDPORT, GND, or GNDPORT via resistor.			
P30-P32	5	I/O	Set these pins in general-purpose input mode in software, and output			
P33/TI50	5-K		low-level signal. Leave unconnected.			
P34/TI51						
P35	5					
P36/BEEP0						
P37						
P40-P47	5-A		Set these pins in general-purpose input mode in software, and connect each of them to GND or GNDPORT via resistor.			
P50-P57	5		Set these pins in general-purpose input mode in software, and connect each of them to VDD, VDDPORT, GND, or GNDPORT via resistor.			
P60-P67	5		Set these pins in general-purpose input mode in software, and output low-level signal. Leave unconnected.			
P70/SI3	5-K		Set these pins in general-purpose input mode in software, and connect each			
P71/SO3	5		of them to VDD, VDDPORT, GND, or GNDPORT via resistor.			
P72/SCK3	5-K					
P73	5					
P74/RXD0	5-K					
P75/TXD0	5					
P76/SDA0	13-R					
P77/SCL0						
P120-P125	5					
P130/TO50	19	Output	Set these pins to low-level output in software and leave unconnected.			
P131/TO51						
P132						
EO0, EO1	DTS-EO1	Output	Leave unconnected.			
VCOL, VCOH	DTS-AMP	Input	Disable PLL in software and select pull-down.			
AMIFC, FMIFC			Set these pins in general-purpose input port mode in software and connect each of them to VDD, VDDPORT, GND, or GNDPORT via resistor.			
REGOSC, REGCPU	-	-	Connect these pins to GND via $0.1-\mu F$ capacitor.			
RESET	2	Input	_			
VDDPLL	-	_	Connect this pin to VDD.			
GNDPLL			Directly connect these pins to GND or GNDPORT.			
Vpp						

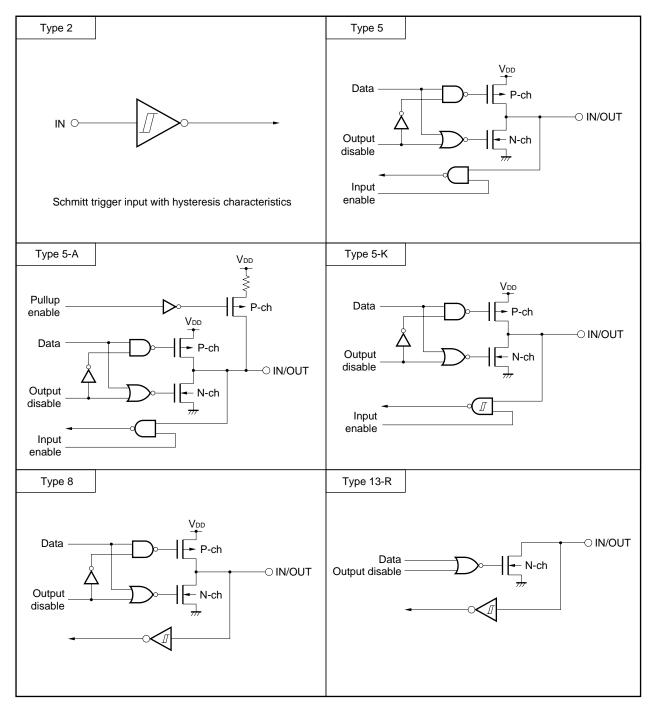


Figure 2-1. I/O Circuits of Respective Pins (1/2)

**Remark** VDD and GND are the positive power supply and ground pins for all port pins. Take VDD and GND as VDDPORT and GNDPORT.

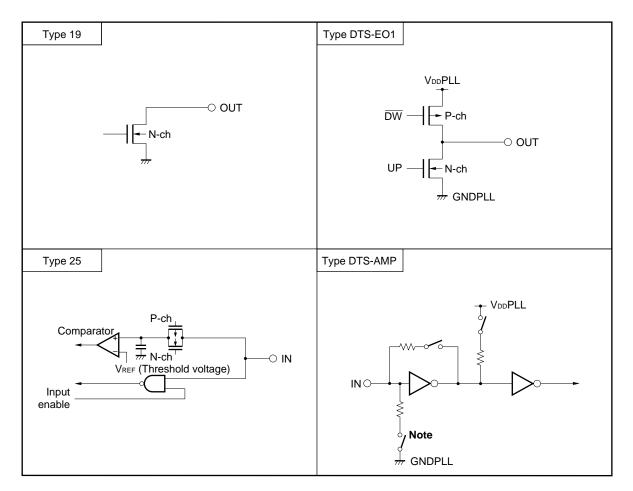


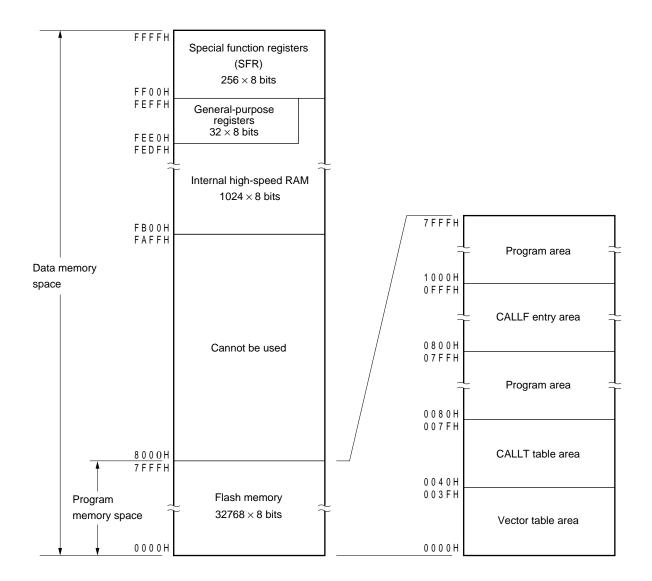
Figure 2-1. I/O Circuits of Respective Pins (2/2)

Note This switch is selectable in software only for the VCOL and VCOH pins.

**Remark** VDD and GND are the positive power supply and ground pins for all port pins. Take VDD and GND as VDDPORT and GNDPORT.

## 3. MEMORY SPACE

Figure 3-1 shows the memory map of the  $\mu$ PD178F124.



#### Figure 3-1. Memory Map

#### 3.1 Memory Size Select Register (IMS)

The memory size select register (IMS) sets the internal memory capacity. When the target mask ROM model is the  $\mu$ PD178023,  $\mu$ PD178024, set this register to C6H, C8H respectively. Use an 8-bit memory manipulation instruction to set the IMS. This register is set to CFH at reset.

# Caution Be sure to set the IMS to C6H or C8H as the program initial setting. The IMS set value changes to CFH when reset. Therefore, set C6H or C8H again after reset.

#### Figure 3-2. Format of Memory Size Select Register (IMS)

Symbol	7	6	5	4	3	2	1	0	Address	At reset	R/W
IMS	RAM2	RAM1	RAM0	0	ROM3	ROM2	ROM1	ROM0	FFF0H	CFH	R/W

RAM2	RAM1	RAM0	Selects Internal High-speed RAM Capacity
1	1	0	1024 bytes
Others	Others		Setting prohibited

RAM3	RAM2	RAM1	RAM0	Selects Flash Memory Capacity
0	1	1	0	24K bytes
1	0	0	0	32K bytes
Others				Setting prohibited

Table 3-1 indicates the setting of IMS to perform the same memory mapping as that of a mask ROM model.

Table 3-1. Set Value of Memory Size Select Register (IMS)

Targeted Model	Set Value of IMS
μPD178023	C6H
μPD178024	C8H

#### 3.2 Internal Extension RAM Size Select Register (IXS)

The internal extension RAM size select register (IXS) sets the internal extension RAM capacity. When the target mask ROM model is the  $\mu$ PD178023,  $\mu$ PD178024, use this register with the initial value (0CH). Use an 8-bit memory manipulation instruction to set the IXS. This register is set to 0CH at reset.

#### Caution Do not assign a value other than that the initial value.

#### Figure 3-3. Format of Internal Extension RAM Size Select Register (IXS)

Symbol	7	6	5	4	3	2	1	0	Address	At reset	R/W
IXS	0	0	0	IXRAM4	IXRAM3	IXRAM2	IXRAM1	IXRAM0	FFF4H	0CH	R/W

IXRAM4	IXRAM3	IXRAM2	IXRAM1	IXRAM0	Selects Internal Extension RAM Capacity
0	1	1	0	0	0 byte
Others					Setting prohibited

Table 3-2 indicates the setting of IXS to perform the same memory mapping as that of a mask ROM model.

#### Table 3-2. Set Value of Internal Extension RAM Size Select Register

Targeted Model	Set Value of IXS
μPD178023, 178024	0CH

## 4. INTERRUPT FUNCTION

The  $\mu$ PD178F124 has the following three types and 17 sources of interrupts:

- Non-maskable : 1Note
- Maskable : 16<sup>Note</sup>
- Software : 1

	Default		Interrupt Source	Internal/	Vector Table	Basic
Interrupt Type	Priority <sup>Note 1</sup>	Name	ne Trigger		Address	Configuration Type <sup>Note 2</sup>
Non-maskable	-	INTWDT	NTWDT Overflow of watchdog timer (when watchdog timer mode 1 is selected)		0004H	(A)
Maskable	0	INTWDT	Overflow of watchdog timer (when interval timer mode is selected)			(B)
	1	INTP0	Pin input edge detection	External	0006H	(C)
	2	INTP1			0008H	
	3	INTP2			000AH	
	4	INTP3			000CH	
	5	INTP4			000EH	
	6	INTKY	Detection of key input of port 4	Internal	0010H	(B)
	7	INTIIC0	End of transfer by serial interface IIC0		0012H	
	8	INTBTM0	Generation of basic timer match signal		0014H	
	9	INTAD3	End of conversion by A/D converter		0016H	
	10	-	_	-	0018H <sup>Note 3</sup>	-
	11	INTCSI3	End of transfer by serial interface SIO3	Internal	001AH	(B)
	12 13	INTTM50	Generation of coincidence signal of 8-bit timer/event counter 50		001CH	
		INTTM51	Generation of coincidence signal of 8-bit timer/event counter 51		001EH	
	14	INTSER0	Reception error of serial interface UART0	]	0020H	
	15	INTSR0	End of reception by serial interface UART0	]	0022H	
	16	INTST0	End of transmission by serial interface UART0		0024H	
Software	_	BRK	Execution of BRK instruction	-	003EH	(D)

Table 4-1. Interrupt Sources

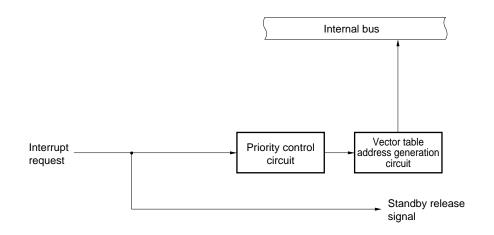
**Notes 1.** If two or more maskable interrupts occur at the same time, they are acknowledged or kept pending according to their default priorities. The default priority 0 is the highest, while 16 is the lowest.

- 2. (A) to (D) under the heading Basic Configuration Type corresponds to (A) to (D) in Figure 4-1.
- 3. There are no interrupt sources corresponding to vector addresses 0018H.

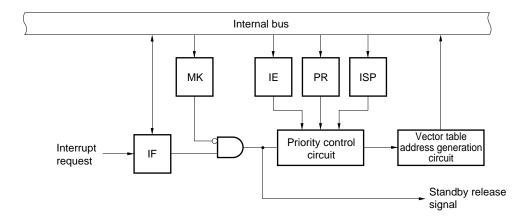
**Note** Two types of watchdog interrupt sources (INTWDT), non-maskable and maskable, are available, and either of them can be selected.

Figure 4-1. Basic Configuration of Interrupt Function (1/2)

(A) Internal non-maskable interrupt



#### (B) Internal maskable interrupt



#### (C) External maskable interrupt

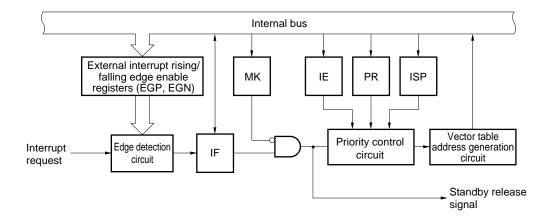
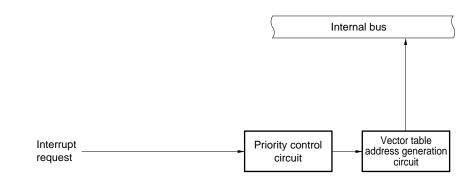


Figure 4-1. Basic Configuration of Interrupt Function (2/2)

(D) Software interrupt



- Remark IF : Interrupt request flag
  - IE : Interrupt enable flag
  - ISP: In-service priority flag
  - MK : Interrupt mask flag
  - PR : Priority specification flag

## 5. FLASH MEMORY PROGRAMMING

The program memory provided in the  $\mu$ PD178F124 is flash memory.

The flash memory can be written on-board, i.e., with the  $\mu$ PD178F124 mounted on the target system.

To do so, connect a dedicated flash writer (Flashpro III (Part number FL-PR3, PG-FP3)) to the host machine and target system.

Remark FL-PR3 is a product of Naito Densei Machida Mfg. Co., Ltd.

#### 5.1 Selecting Communication Mode

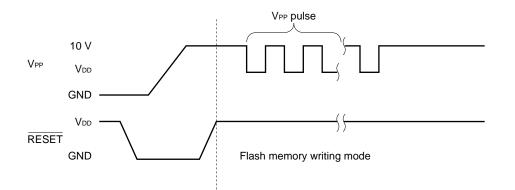
The flash memory is written by using Flashpro III and by means of serial communication. Select a communication mode from those listed in Table 5-1. To select a communication mode, the format shown in Figure 5-1 is used. Each communication mode is selected depending on the number of VPP pulses shown in Table 5-1.

Communication Mode	Number of Channels	Pins Used	Number of VPP Pulses
3-wire serial I/O (SIO3)	1	SI3/P70	0
		SO3/P71	
		SCK3/P72	
UART0	1	RXD0/P74	8
		TXD0/P75	

#### Table 5-1. Communication Modes

#### Caution Be sure to select a communication mode by the number of VPP pulses shown in Table 6-1.

Figure 5-1. Communication Mode Selection Format



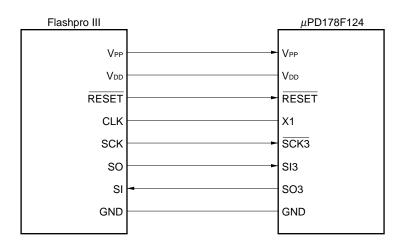
## 5.2 Flash Memory Programming Function

An operation such as writing the flash memory is performed when a command or data is transmitted/received in the selected communication mode. The major flash memory programming functions are listed in Table 5-2.

Function	Description
Batch erase	Erases all memory contents.
Batch blank check	Checks erased status of entire memory.
Data write	Writes data to flash memory starting from write start address and based on number of data (bytes) to be written).
Batch verify	Compares all contents of memory with input data.

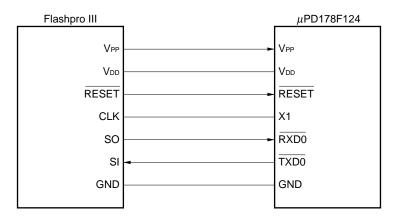
## 5.3 Connecting Flashpro III

Connection with Flashpro III differs depending on the communication mode (3-wire serial I/O or UART0). Figures 5-2 and 5-3 show the connection in the respective modes.



#### Figure 5-2. Connection of Flashpro III in 3-Wire Serial I/O Mode





## 6. ELECTRICAL SPECIFICATIONS

#### Absolute Maximum Ratings (T<sub>A</sub> = $25^{\circ}$ C)

Parameter	Symbol	Conditions			Rating	Unit
Supply voltage	Vdd				-0.3 to +6.0	V
					-0.3 to V <sub>DD</sub> + 0.3 <sup>Note 1</sup>	V
	VDDPLL				-0.3 to V <sub>DD</sub> + 0.3 <sup>Note 1</sup>	V
	Vpp				-0.3 to +10.5	V
Input voltage	Vi				-0.3 to VDD + 0.3	V
Output voltage	Vo	Excluding P130	to P132		-0.3 to VDD + 0.3	V
Output breakdown voltage	VBDS	P130-P132	N-ch open drain		16	V
Analog input voltage	Van	P10-P15	Analog input pin		-0.3 to VDD + 0.3	V
High-level output	Іон	1 pin		-8	mA	
current		Total of P00-P0 and P120-P125	6, P30-P37, P54-P57, I	-15	mA	
		Total of P40-P4	7, P50-P53, and P70-P	-15	mA	
Low-level output	IOL <sup>Note 2</sup>	1 pin		Peak value	16	mA
current				r.m.s	8	mA
		Total of P00-P0	6, P30-P37, P40-P47,	Peak value	30	mA
P50-P57, P60-P67, P70-P77 P120-P125, and P130-P132		, ,	r.m.s	15	mA	
Operating temperature	TA	During normal operation			-40 to +85	°C
		During flash me	mory programming	10 to 40	°C	
Storage temperature	Tstg				-55 to +125	°C

Notes 1. Keep the voltage at VDDPORT and VDDPLL same as that at the VDD pin.

2. Calculate the r.m.s as follows:  $[r.m.s] = [Peak value] x \sqrt{Duty}$ 

- Caution If the rated value of even one of the above parameters is exceeded even momentarily, the quality of the product may be degraded. The absolute maximum ratings, therefore, are the values exceeding which the product may be physically damaged. Be sure to use the product with these ratings never being exceeded.
- **Remark** Unless otherwise specified, the characteristics of a multiplexed pin are the same as those of the corresponding port pin.

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Supply voltage	Vdd1	When CPU and PLL are operating	4.5	5.0	5.5	V
	Vdd2	When CPU is operating and PLL is stopped	3.5	5.0	5.5	V
Data retention voltage	Vddr	When crystal oscillation stops	2.3		5.5	V
Output breakdown voltage	VBDS	P130-P132 (N-ch open drain)			15	V

#### Recommended Supply Voltage Ranges ( $T_A = -40$ to $+85^{\circ}C$ )

## DC Characteristics (TA = -40 to +85°C, VDD = 3.5 to 5.5 V) (1/2)

Parameter	Symbol	Test Con	ditions	MIN.	TYP.	MAX.	Unit
High-level input voltage	VIH1	P10-P15, P30-P32, P35-P3 P60-P67, P71, P73, P120-F		0.7 Vdd		Vdd	V
	Vih2	P00-P06, P33, P34, P70, P	72, P74-P75, RESET	0.8 Vdd		Vdd	V
	Vінз	P76, P77 (N-ch open-drain I/O)	$4.5 \text{ V} \leq \text{V}_{\text{DD}} \leq 5.5 \text{ V}$	0.7 Vdd		Vdd	V
Low-level input voltage	VIL1		P10-P15, P30-P32, P35-P37, P40-P47, P50-P57, P60-P67, P71, P73, P120-P125				V
	VIL2	P00-P06, P33, P34, P70, P	72, P74-P75, RESET	0		0.2 Vdd	V
	VIL3	P76, P77 (N-ch open-drain I/O)	$4.5 \text{ V} \leq \text{V}_{\text{DD}} \leq 5.5 \text{ V}$	0		0.3 Vdd	V
High-level output voltage	Vон1	P00-P06, P30-P37, P40-P47, P50-P57,	$4.5 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V},$ Ioh = -1 mA	Vdd - 1.0			V
		P60-P67, P70-P77, P120-P125	3.5 V ≤ Vdd < 4.5 V, Іон = −100 µА	Vdd - 0.5			V
	Vон2	EO0, EO1	Vdd = 4.5 to 5.5 V, Іон = -3 mA	Vdd - 1.0			V
Low-level output voltage	Vol1		$4.5 \text{ V} \leq \text{V}_{\text{DD}} \leq 5.5 \text{ V},$ $\text{Iol} = 1 \text{ mA}$			1.0	V
		P70-P75, P120-P125	$3.5 \text{ V} \le \text{V}_{\text{DD}} < 4.5 \text{ V},$ Iol = 100 $\mu$ A			0.5	V
	Vol2	EO0, EO1	VDD = 4.5 to 5.5 V, IOL = 3 mA			1.0	
	Vol3	P76, P77 (N-ch open-drain I/O)	$4.5 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}$ Iol = 3 mA			0.4	V
			$4.5 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}$ Iol = 6 mA			0.6	V
High-level input leakage current	ILн	P00-P06, P10-P15, P30-P37, P40-P47, P50-P57, P60-P67, P70-P77, P120-P125, RESET	Vin = Vdd			3	μΑ

**Remark** Unless otherwise specified, the characteristics of a multiplexed pin are the same as those of the corresponding port pin.

Parameter	Symbol	Test Con	ditions	MIN.	TYP.	MAX.	Unit
Low-level input leakage current	ILIL.	P00-P06, P10-P15, P30-P37, P40-P47, P50-P57, P60-P67, P70-P77, P120-P125, RESET	Vin = 0 V			-3	μΑ
Output off	ILOH1	P130-P132	Vout = 15 V			-3	μA
leakage current	ILOL1	P130-P132	Vout = 0 V			3	μA
	Iloh2	P76, P77 (at N-ch open drain I/O)	Vout = Vdd			-3	μA
	ILOL2	P76, P77 (at N-ch open drain I/O)	Vout = 0 V			3	μA
	Ігонз	EO0, EO1	Vout = Vdd			-3	μA
	ILOL3	EO0, EO1	Vout = 0 V			3	μA
Supply current <sup>Note</sup>	Idd1	When CPU is operating and Sine wave input to X1 pin At $fx = 4.5 \text{ MHz}$ VIN = VDD		5.0	18	mA	
	Idd2	In HALT mode with PLL stopped. Sine wave input to X1 pin At fx = 4.5 MHz VIN = VDD			0.3	0.8	mA
Data retention	VDDR1	When crystal resonator is o	scillating	3.5		5.5	V
voltage	Vddr2	When crystal oscillation is stopped	Power-failure detection function	2.2			V
	Vddr3		Data memory retained	2.0			V
Data retention current	IDDR1	When crystal oscillation is stopped	$T_{A} = 25^{\circ}C,$ $V_{DD} = 5 V$		2.0	4.0	μA
	IDDR2				2.0	20	μA

DC Characteristics (TA = -40 to +85°C, VDD = 3.5 to 5.5 V) (2/2)

**Note** Excluding AVDD current and VDDPLL current.

Remarks 1. fx: System clock oscillation frequency

**2.** Unless otherwise specified, the characteristics of a multiplexed pin are the same as those of the corresponding port pin.

## Reference Characteristics (T<sub>A</sub> = -40 to $+85^{\circ}$ C, V<sub>DD</sub> = 4.5 to 5.5 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Supply current	Idd3	When CPU and PLL are operating. Sine wave input to VCOH pin At $f_{IN} = 160 \text{ MHz}$ $V_{IN} = 0.15 \text{ V}_{P-P}$		5		mA

#### **AC Characteristics**

## (1) Basic operation (T<sub>A</sub> = -40 to +85°C, V<sub>DD</sub> = 3.5 to 5.5 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Cycle time (minimum instruction execution time)	Тсү	fx = 4.5 MHz	0.44		7.11	μs
TI50, TI51 input frequency	fti5				2	MHz
TI50, TI51 input high-/low-level widths	t⊤iн5 t⊤i∟5		200			ns
Interrupt input high-/low-level widths	tinth tintl	INTP0-INTP4	1			μs
RESET pin low-level width	trsl		10			μs

(2) Serial interface (TA = -40 to  $+85^{\circ}$ C, VDD = 3.5 to 5.5 V)

#### (a) Serial interface (IIC0)

#### I<sup>2</sup>C bus mode

	Parameter	Symbol	Standar	rd Mode	High-spe	ed Mode	Unit
			MIN.	MAX.	MIN.	MAX.	
SCL0 clock	frequency	fськ	0	100	0	400	kHz
Bus free time (between stop and start conditions)		tвuғ	4.7	_	1.3	_	μs
Hold time <sup>No</sup>	ote 1	thd : STA	4.0	_	0.6	_	μs
SCL0 clock	low-level width	tLOW	4.7	_	1.3	-	μs
SCL0 clock	SCL0 clock high-level width		4.0	-	0.6	-	μs
Start/restar	t condition setup time	tsu : sta	4.7	-	0.6	-	μs
Data hold	CBUS compatible master	<b>t</b> hd : dat	5.0	-	-	-	μs
time	l <sup>2</sup> C bus		O <sup>Note 2</sup>	-	ONote 2	0.9 <sup>Note 3</sup>	μs
Data setup	time	tsu : dat	250	_	100 <sup>Note 4</sup>	_	ns
SDA0 and	SCL0 signal rise time	tR	-	1000	20+0.1Cb <sup>Note 5</sup>	300	ns
SDA0 and	SCL0 signal fall time	t⊧	_	300	20+0.1Cb <sup>Note 5</sup>	300	ns
Stop condit	ion setup time	tsu : sto	4.0	_	0.6	_	μs
Pulse width	of spike restrained by input filter	tsp	-	_	0	50	ns
Each bus li	ne capacitative load	Cb	-	400	-	400	pF

Notes 1. The first clock pulse is generated at the start condition after this period.

- 2. The device needs to internally supply a hold time of at least 300 ns for the SDA0 signal to fill the undefined area at the falling edge of the SCL0 (VIHmin. of the SCL0 signal).
- 3. Unless the device extends the low hold time (tLow) of the SCL0 signal, it is necessary to fill only the maximum data hold time (tHD : DAT).
- 4. The high-speed mode I<sup>2</sup>C bus can be used in the standard mode I<sup>2</sup>C bus system. In this case, satisfy the following conditions:
  - When the device does not extend the low hold time of the SCL0 signal tsu :  $\mbox{DAT} \geq 250 \mbox{ ns}$
  - When the device extends the low hold time of the SCL0 signal Send the next data bit to the SDA line before releasing the SCL0 line (t<sub>Rmax</sub>. + t<sub>SU:DAT</sub> = 1000 + 250 = 1250 ns : in the standard mode I<sup>2</sup>C bus specification)
- 5. Cb: Total capacitance of one bus line (unit: pF)

#### (b) Serial interface (SIO3)

#### (i) 3-wire serial I/O mode (SCK3 ... internal clock output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
SCK3 cycle time	tkcy1		800			ns
SCK3 high/low-level width	tкнı,		tксү1/2 — 50			ns
	tĸ∟1					
SI3 setup time (to SCK3↑)	tsik1		100			ns
SI3 hold time (from SCK3↑)	tksi1		400			ns
$\overline{\text{SCK3}}{\downarrow}{\rightarrow}$ SO3 output delay time	tkso1	C = 100 pF <sup>Note</sup>			300	ns

**Note** C is the load capacitance of  $\overline{SCK3}$  and SO3 output line.

#### (ii) 3-wire serial I/O mode (SCK3 ... external clock input)

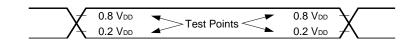
Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
SCK3 cycle time	tксү2		800			ns
SCK3 high/low-level width	tкн2,		400			ns
	tĸ∟2					
SI3 setup time (to SCK3↑)	tsik2		100			ns
SI3 hold time (from SCK3 <sup>↑</sup> )	tksi2		400			ns
$\overline{\text{SCK3}}{\downarrow}{\rightarrow}$ SO3 output delay time	tkso2	C = 100 pF <sup>Note</sup>			300	ns
SCK3 at rising or falling edge time	tr2, tr2				1000	ns

**Note** C is the load capacitance of SO3 output line.

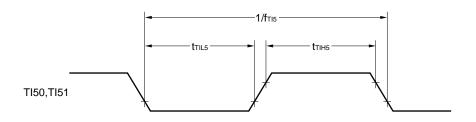
#### (d) Serial interface (UART0: Dedicated baud rate generator output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate					38400	bps

## AC Timing Test Point (Excluding X1 Input)



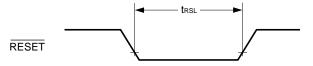
**TI** Timing



Interrupt Input Timing

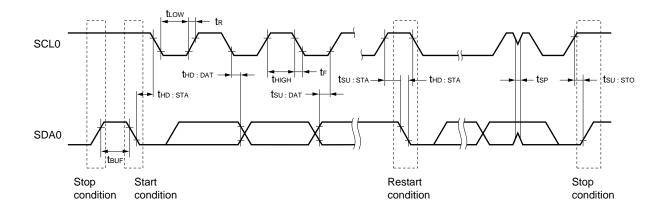


**RESET** Input Timing

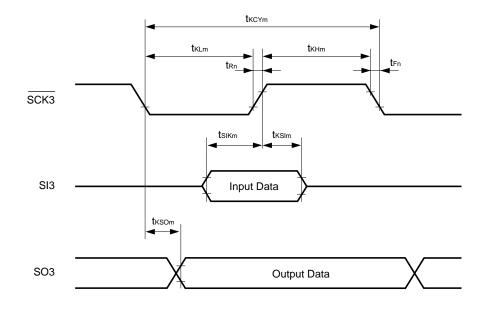


#### Serial Transfer Timing

I<sup>2</sup>C bus mode:



3-wire serial I/O mode:



**Remark** m = 1, 2 n = 2

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution			8	8	8	bit
Total conversion		V <sub>DD</sub> = 4.5 ~ 5.5 V			±1.0	%
error <sup>Note</sup>					±1.4	%
Conversion time	tCONV		21.3		64.0	μs
Analog input voltage	Vian		0		Vdd	V

#### A/D Converter Characteristics ( $T_A = -40$ to $+85^{\circ}C$ , $V_{DD} = 3.5$ to 5.5 V)

**Note** Excluding quantization error (±1/2LSB)

#### PLL Characteristics (T<sub>A</sub> = -40 to +85°C, V<sub>DD</sub> = 4.5 to 5.5 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Operating frequency	fin1	VCOL pin, MF mode, sine wave input, $V_{\text{IN}}$ = 0.15 $V_{\text{P-P}}$	0.5		3.0	MHz
	fin2	VCOL pin, HF mode, sine wave input, VIN = 0.15 VP-P	10		40	MHz
	finз	VCOH pin, VHF mode, sine wave input, VIN = 0.15 VP-P	60		130	MHz
	fin4	VCOH pin, VHF mode, sine wave input, $V_{\text{IN}}$ = 0.3 $V_{\text{P-P}}$	40		160	MHz

## IFC Characteristics (TA = -40 to +85°C, VDD = 4.5 to 5.5 V)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Operating frequency	fin5	AMIFC pin, AMIF count mode, sine wave input, $V_{IN} = 0.15 V_{P-P}$	0.4		0.5	MHz
	fin6	FMIFC pin, FMIF count mode, sine wave input, $V_{IN} = 0.15 V_{P-P}$	10		11	MHz
	fin7	FMIFC pin, AMIF count mode, sine wave input, $V_{IN} = 0.15 V_{P-P}$	0.4		0.5	MHz

Flash Memory Programming Characteristics (V<sub>DD</sub> = 3.5 to 5.5 V, T<sub>A</sub> = 10 to 40°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Write current (V <sub>DD</sub> pin) <sup>Note</sup>	todw	When $V_{PP} = V_{PP1}$ , fx = 4.5 MHz			20	mA
Write current (VPP pin) <sup>Note</sup>	IPPW	When $V_{PP} = V_{PP1}$ , fx = 4.5 MHz			20	mA
Delete current (VDD pin)Note	Idde	When $V_{PP} = V_{PP1}$ , fx = 4.5 MHz			20	mA
Delete current (VPP pin)Note	IPPE	When VPP = VPP1			100	mA
Unit delete time	ter		0.5	1	1	S
Total delete time	tera				20	s
Number of overwrite	CWRT	Delete and write are counted as one cycle			20	times
VPP power supply voltage	Vpp0	In normal mode	0		0.2 Vdd	V
	Vpp1	At flash memory programming	9.7	10.0	10.3	V

#### (1) Write/delete characteristics

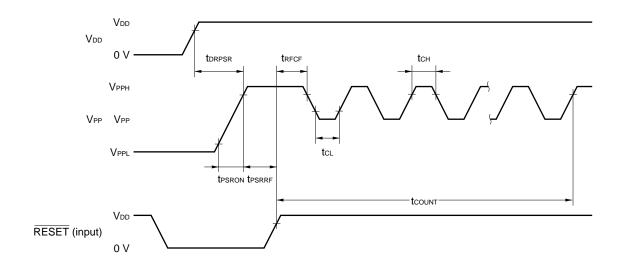
Note AVDD current and Port current (current flowing to internal pull-up resistor) are not included.

Remark fx: System clock oscillation frequency

## (2) Serial write operation characteristics

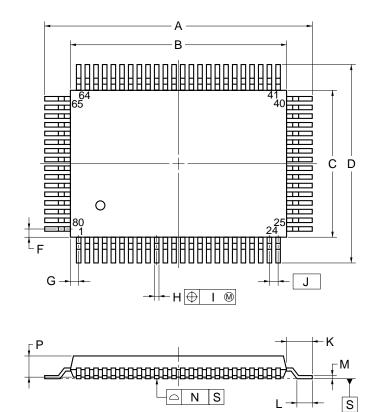
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
VPP setup time	<b>t</b> PSRON	VPP high voltage	1.0			μs
V <sub>PP</sub> ↑ setup time from V <sub>DD</sub> ↑	<b>t</b> drpsr	VPP high voltage	1.0			μs
$\overline{RESET} \uparrow \text{ setup time from } V_{PP} \uparrow$	<b>t</b> PSRRF	VPP high voltage	1.0			μs
VPP count start time from RESET	<b>t</b> rfcf		1.0			μs
Count execution time	<b>t</b> COUNT				2.0	ms
VPP counter high-level width	tсн		8.0			μs
VPP counter low-level width	tc∟		8.0			μs
VPP counter noise elimination width	tNFW			40		ns

# Flash Write Mode Setting Timing

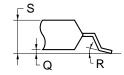


# 7. PACKAGE DRAWING

# 80-PIN PLASTIC QFP (14x20)



detail of lead end



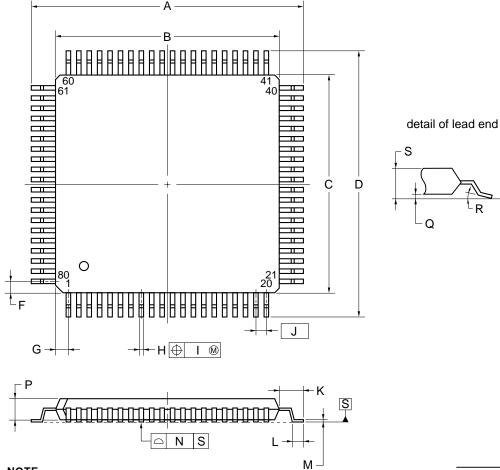
#### NOTE

Each lead centerline is located within 0.15 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS
Α	23.6±0.4
В	20.0±0.2
С	14.0±0.2
D	17.6±0.4
F	1.0
G	0.8
н	$0.37\substack{+0.08\\-0.07}$
I	0.15
J	0.8 (T.P.)
К	1.8±0.2
L	0.8±0.2
М	$0.17\substack{+0.08\\-0.07}$
N	0.10
Р	2.7±0.1
Q	0.1±0.1
R	5°±5°
S	3.0 MAX.
	P80GF-80-3B9-5

R

# 80-PIN PLASTIC QFP (14x14)



#### NOTE

Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS
А	17.20±0.20
В	14.00±0.20
С	14.00±0.20
D	17.20±0.20
F	0.825
G	0.825
Н	0.32±0.06
I	0.13
J	0.65 (T.P.)
К	1.60±0.20
L	0.80±0.20
М	$0.17\substack{+0.03 \\ -0.07}$
N	0.10
Р	1.40±0.10
Q	0.125±0.075
R	$3^{\circ+7^{\circ}}_{-3^{\circ}}$
S	1.70 MAX.
	P80GC-65-8BT-1

# 8. RECOMMENDED SOLDERING CONDITIONS

Solder this product under the following recommended conditions.

For details of the recommended soldering conditions, refer to information document **Semiconductor Device Mounting Technology Manual (C10535E)**.

For soldering methods and conditions other than those recommended, consult NEC.

#### Table 8-1. Soldering Conditions for Surface-Mount Type

 $\mu$ PD178F124GF-3B9: 80-pin plastic QFP (14  $\times$  20)

Soldering Method	Soldering Conditions	Recommended Conditions Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 sec max. (210°C min.), Number of times: 3 max.	IR35-00-3
VPS	Package peak temperature: 215°C, Time: 40 sec max. (200°C min.), Number of times: 3 max.	VP15-00-3
Wave soldering	Solder bath temperature: 260°C max., Time: 10 sec max., Number of times: 1, Preheating temperature: 120°C max., (Package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C max., Time: 3 sec max (per device side)	-

#### Caution Do not use two or more soldering methods in combination (except partial heating).

#### $\mu$ PD178F124GC-8BT: 80-pin plastic QFP (14 × 14)

Soldering Method	Soldering Conditions	Recommended Conditions Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 sec max. (210°C min.), Number of times: 2 max.	IR35-00-2
VPS	Package peak temperature: 215°C, Time: 40 sec max. (200°C min.), Number of times: 2 max.	VP15-00-2
Wave soldering	Solder bath temperature: 260°C max., Time: 10 sec max., Number of times: 1, Preheating temperature: 120°C max., (Package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C max., Time: 3 sec max (per device side)	-

Caution Do not use two or more soldering methods in combination (except partial heating).

# APPENDIX A. DEVELOPMENT TOOLS

The following development tools are available for development of systems using the  $\mu$ PD178F124.

#### (1) Language processor software

RA78K0 <sup>Notes 1, 2, 3</sup>	Assembler package common to 78K/0 series
CC78K0 <sup>Notes 1, 2, 3</sup>	C compiler package common to 78K/0 series
DF178124 <sup>Notes 1, 2, 3</sup>	Device file for $\mu$ PD178024 subseries
CC78K0-L <sup>Notes 1, 2, 3</sup>	C compiler library source file common to 78K/0 series

#### (2) Flash memory writing tools

Fashpro III (Part number: FL-PR3 <sup>Note 4</sup> , PG-FP3)	Dedicated flash writer
FA-80GF <sup>Note 4</sup>	Flash memory writing adapter
FA-80GC-8BT <sup>Note 4</sup>	

## (3) Debugging tools

#### • When in-circuit emulator IE-78K0-NS is used

In-circuit emulator common to 78K/0 series
Power supply unit for IE-78K0-NS
Performance board for enhancing and expanding the IE-78K0-NS function
Interface adapter necessary when a PC-9800 series (except notebook-type PC) is used as host machine (C bus supported)
PC card and interface cable necessary when a notebook-type PC is used as host machine (PCMCIA socket supported)
Interface adapter when a IBM PC/AT <sup>TM</sup> compatible machine is used (ISA bus supported)
Interface adapter necessary when a PC with a PCI bus is used as host machine
Emulation board for emulating the $\mu$ PD178024 subseries
Emulation probe for 80-pin plastic QFP (GF-3B9 type)
Socket to be mounted on the board of the target system for 80-pin plastic QFP (GF-3B9 type)
Emulation probe for 80-pin plastic QFP (GC-8BT type)
Socket to be mounted on the board of the target system for 80-pin plastic QFP (GC-8BT type)
System simulator common to 78K/0 series
Integrated debugger common to 78K/0 series
Device file for $\mu$ PD178024 subseries

**Notes 1.** PC-9800 series (Japanese Windows<sup>™</sup>) based

- 2. IBM PC/AT compatible machine (Japanese/English Windows) based
- HP9000 series 700<sup>™</sup> (HP-UX<sup>™</sup>) based, SPARCstation<sup>™</sup> (SunOS<sup>™</sup>, Solaris<sup>™</sup>) based, NEWS<sup>™</sup> (NEW-OS<sup>™</sup>) based
- 4. Products of Naito Densei Machida Mfg. Co., Ltd. (Tel: 044-822-3813).

Remark Use the RA78K0, CC78K0, and SM78K0 in combination with the DF178124.

#### • When in-circuit emulator IE-78001-R-A is used

IE-78001-R-A	In-circuit emulator common to 78K/0 series
IE-70000-98-IF-C	Interface adapter necessary when a PC-9800 series (except notebook-type PC) is used as host machine (C bus supported)
IE-70000-PC-IF-C	Interface adapter when a IBM PC/AT compatible machine is used (ISA bus supported)
IE-70000-PCI-IF	Interface adapter necessary when a PC with a PCI bus is used as host machine
IE-78000-R-SV3	Interface adapter and cable necessary when an EWS is used as host machine
IE-178134-NS-EM1	Emulation board for emulating the $\mu$ PD178024 subseries
IE-78K0-R-EX1	Emulation probe conversion board necessary when using IE-178134-NS-EM1 on IE-78001-R-A.
EP-78130GF-R	Emulation probe for 80-pin plastic QFP (GF-3B9 type)
EV-9200G-80	Socket to be mounted on the board of the target system for 80-pin plastic QFP (GF-3B9 type)
EP-78230GC-R	Emulation probe for 80-pin plastic QFP (GC-8BT type)
EV-9200GC-80	Socket to be mounted on the board of the target system for 80-pin plastic QFP (GC-8BT type)
SM78K0 <sup>Notes 1, 2</sup>	System simulator common to 78K/0 series
ID78K0 <sup>Notes 1, 2</sup>	Integrated debugger common to 78K/0 series
DF178124 <sup>Notes 1, 2, 3</sup>	Device file for $\mu$ PD178024 subseries

#### Real-time OS

RX78K0 <sup>Notes 1, 2, 3</sup>	Real-time OS for 78K/0 series
MX78K0 <sup>Notes 1, 2, 3</sup>	OS for 78K/0 series

Notes 1. PC-9800 series (Japanese Windows) based

- 2. IBM PC/AT compatible machine (Japanese/English windows) based
- 3. HP9000 series 700 (HP-UX) based, SPARCstation (SunOS, Solaris) based, NEWS (NEW-OS) based

Remark Use SM78K0 in combination with the DF178124.

# APPENDIX B. RELATED DOCUMENTS

The related documents indicated in this publication may include preliminary versions. However, preliminary versions are not marked as such.

# **Device Documents**

Title		Document No.	
		Japanese	English
μPD178023, 178024 Data Sheet		U14126J	U14126E
μPD178F124 Data Sheet		U14933J	This document
μPD178024, 178124 Subseries User's Manual		U13915J	U13915E
78K/0 Series User's Manual—Instruction		U12326J	U12326E
78K/0 Series Application Note Basics (I)		U12704J	U12704E
78K/0, 78K/0S Series Flash Memory Write Application Note		U14458J	U14458E

## **Development Tool Documents (User's Manual)**

Title		Document No.	
		Japanese	English
RA78K0 Assembler Package	Operation	U11802J	U11802E
	Assembly Language	U11801J	U11801E
	Structured Assembly Language	U11789J	U11789E
CC78K0 C Compiler	Operation	U11517J	U11517E
	Language	U11518J	U11518E
PG-FP3 Flash Memory Programmer		U13502J	U13502E
IE-78001-R-A In-circuit Emulator		U14142J	To be prepared
IE-78K0-NS In-circuit Emulator		U13731J	U13731E
IE-178134-NS-EM1 Emulation Board		To be prepared	To be prepared
EP-78230 Emulation Probe		EEU-985	EEU-1515
EP-78130 Emulation Probe		_	EEU-1470
SM78K0 System Simulator Windows Based	Reference	U10181J	U10181E
SM78K Series System Simulator	External Parts User Open Interface Specifications	U10092J	U10092E
ID78K0 Integrated Debugger EWS Based	Reference	U11151J	-
ID78K0 Integrated Debugger PC Based	Reference	U11539J	U11539E
ID78K0 Integrated Debugger Windows Based	Guide	U11649J	U11649E
ID78K0-NS Integrated Debugger Windows Based	Operation	U14379J	U14379E
ID78K0-NS, ID78K0S-NS Integrated Debugger Ver. 2.20 Windows Based	Operation	U14910J	To be prepared

Caution The contents of the above documents are subject to change without notice. Please ensure that the latest versions are used in design work, etc.

# Related Documents for Embedded Software (User's Manual)

Title		Document No.	
		Japanese	English
78K/0 Series Real-time OS	Fundamental	U11537J	U11537E
	Installation	U11536J	U11536E
78K/0 Series OS MX78K0	Fundamental	U12257J	U12257E

# **Other Documents**

Title	Document No.	
	Japanese	English
SEMICONDUCTOR SELECTION GUIDE Products & Packages (CD-ROM)	X13769X	
Semiconductor Device Mounting Technology Manual	C10535J	C10535E
Quality Guides on NEC Semiconductor Devices	C11531J	C11531E
NEC Semiconductor Device Reliability and Quality Control	C10983J	C10983E
Guide to Prevent Damage for Semiconductor Devices by Electrostatic Discharge (ESD)	C11892J	C11892E
Semiconductor Device Quality/Reliability Handbook	C12769J	—
Microcomputer Product Series Guide	U11416J	—

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# - NOTES FOR CMOS DEVICES -

# **①** PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

#### Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

#### **(2)** HANDLING OF UNUSED INPUT PINS FOR CMOS

#### Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

#### **③** STATUS BEFORE INITIALIZATION OF MOS DEVICES

#### Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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Fax: 02-66 75 42 99	Tel: 08-63 80 820	NEC do Brasil S.A.
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		Electron Devices Division
		Guarulhos-SP Brasil
		Tel: 55-11-6462-6810

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